	Application/Control No.	Applicant(s)/Patent Under Reexamination
Issue Classification	10675664	NIEDERDRANK, TORSTEN
	Examiner	Art Unit
	Ensey, Brian	2615

		Lisey, Dian		:		2					
	ORIGINAL	AL			Z	INTERNATIONAL CLASSIFICATION	CLAS	SIFI	CATIO	Z	
	CLASS	SUBCLASS			CLAIMED	ED			NON-C	NON-CLAIMED	
381	8	317	О <u>Т</u>	4	œ	25 / 00	I	0 4	æ	2	25 / 00
	CROSS REFERENCE(S)	RENCE(S)						-			
CLASS	SUBCLASS (ON	SUBCLASS (ONE SUBCLASS PER BLOCK)									
381	315					•		_			
								\dashv			
								\dashv			
								<u> </u>			
								\dashv			
								H			
										1	
			**					-			Ī
								\dashv			
				4				\dashv			
				_			•	+			
				4				\dashv			
Brian Ensey	777 2007/00/20	SINH TRAN	NA NA		۲	しつかりて		1	otal Clai	Total Claims Allowed:	
(Assistant Examiner)	4	SUPERUIT	ENT EX	AMIN MIN	EB					18	
V							0.G.	Print	O.G. Print Claim(s)	O.G. Print Figure	gure
(Legal Instruments Examiner)	ents Examiner) (Date)	(Primary Examiner)		(Date)	_			-		-	
											386

U.S. Patent and Trademark Office